

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10531952	TANAKA ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Darcy D LaClair	4171	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
524	502	4/2/2008	/DDL/
156	327, 336	1/8/2009	/DDL/
428	35.2, 35.7, 36.92, 480	1/8/2009	/DDL/
523	124	1/8/2009	/DDL/
524	47, 292, 294, 296, 297, 306, 310, 311, 312, 313, 315, 317, 320, 502	1/8/2009	/DDL/
525	410, 411, 413, 415, 437, 444, 447, 450, 451	1/8/2009	/DDL/
528	272, 308, 354, 355, 359, 361	1/8/2009	/DDL/
604	212, 370, 403, 408	1/8/2009	/DDL/
524	502 604 605 437	1/28/2010	/DDL/
525	438 439 444 444.5 447 448 450 451	1/28/2010	/DDL/
528	272	1/28/2010	/DDL/

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Reviewed submitted prior art and searched patent family information in EAST	4/2/2008	/DDL/
See EAST search History	4/3/2008	/DDL/
Inventor search in eDAN	4/3/2008	/DDL/
Reviewed concepts and sought additional chemical data via a web based search	6/4/2008	/DDL/
Updated Inventor search	1/8/2009	/DDL/
See Updated Search History	1/8/2009	/DDL/
Updated Inventor Search	10/16/2009	/DDL/
Updated EAST search	10/16/2009	/DDL/
Reviewed IDS submissions	10/16/2009	/DDL/
Updated EAST search, inventor search	1/28/2010	/DDL/
Extensive discussion with Examiner Nerangis; search strategy, application of 103	1/28/2010	/DDL/
Consulted STIC for property search		

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
/D. D. L./ Examiner Art Unit 1796			

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/D. D. L./  
Examiner Art Unit 1796